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# SGP13N60UF

## Ultra-Fast IGBT

### General Description

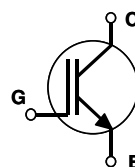
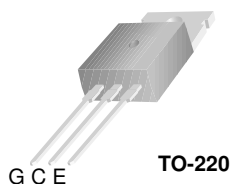
Fairchild's UF series of Insulated Gate Bipolar Transistors (IGBTs) provides low conduction and switching losses. The UF series is designed for applications such as motor control and general inverters where high speed switching is a required feature.

### Features

- High speed switching
- Low saturation voltage :  $V_{CE(sat)} = 2.1 \text{ V @ } I_C = 6.5\text{A}$
- High input impedance

### Applications

AC & DC motor controls, general purpose inverters, robotics, and servo controls.



### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

| Symbol             | Description   | SGP13N60UF  | Units |
|--------------------|---|-------------|-------|
| V <sub>CES</sub>   | Collector-Emitter Voltage   | 600         | V     |
| V <sub>GES</sub>   | Gate-Emitter Voltage  | ± 20        | V     |
| I <sub>C</sub>     | Collector Current @ T <sub>C</sub> = 25°C                               | 13          | A     |
|                    | Collector Current @ T <sub>C</sub> = 100°C                              | 6.5         | A     |
| I <sub>CM(1)</sub> | Pulsed Collector Current  | 52          | A     |
| P <sub>D</sub>     | Maximum Power Dissipation @ T <sub>C</sub> = 25°C                       | 60          | W     |
|                    | Maximum Power Dissipation @ T <sub>C</sub> = 100°C                      | 25          | W     |
| T <sub>J</sub>     | Operating Junction Temperature  | -55 to +150 | °C    |
| T <sub>stg</sub>   | Storage Temperature Range   | -55 to +150 | °C    |
| T <sub>L</sub>     | Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds | 300         | °C    |

**Notes :**

(1) Repetitive rating : Pulse width limited by max. junction temperature

### Thermal Characteristics

| Symbol           | Parameter                               | Typ. | Max. | Units |
|------------------|---|------|------|-------|
| R <sub>θJC</sub> | Thermal Resistance, Junction-to-Case    | --   | 2.0  | °C/W  |
| R <sub>θJA</sub> | Thermal Resistance, Junction-to-Ambient | --   | 62.5 | °C/W  |

**Electrical Characteristics of the IGBT**  $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol                               | Parameter                                    | Test Conditions                 | Min. | Typ. | Max.      | Units               |
|--------------------------------------|--|---------------------------------|------|------|-----------|---------------------|
| <b>Off Characteristics</b>           |  |                                 |      |      |           |                     |
| $BV_{CES}$                           | Collector-Emitter Breakdown Voltage          | $V_{GE} = 0V, I_C = 250\mu A$   | 600  | --   | --        | V                   |
| $\frac{\Delta BV_{CES}}{\Delta T_J}$ | Temperature Coefficient of Breakdown Voltage | $V_{GE} = 0V, I_C = 1mA$        | --   | 0.6  | --        | V/ $^\circ\text{C}$ |
| $I_{CES}$                            | Collector Cut-Off Current                    | $V_{CE} = V_{CES}, V_{GE} = 0V$ | --   | --   | 250       | $\mu A$             |
| $I_{GES}$                            | G-E Leakage Current                          | $V_{GE} = V_{GES}, V_{CE} = 0V$ | --   | --   | $\pm 100$ | nA                  |

**On Characteristics**

|               |   |                                |     |     |     |   |
|---------------|---|--------------------------------|-----|-----|-----|---|
| $V_{GE(th)}$  | G-E Threshold Voltage                   | $I_C = 6.5mA, V_{CE} = V_{GE}$ | 3.5 | 4.5 | 6.5 | V |
| $V_{CE(sat)}$ | Collector to Emitter Saturation Voltage | $I_C = 6.5A, V_{GE} = 15V$     | --  | 2.1 | 2.6 | V |
|               |   | $I_C = 13A, V_{GE} = 15V$      | --  | 2.6 | --  | V |

**Dynamic Characteristics**

|           |                              |  |    |     |    |    |
|-----------|------------------------------|--|----|-----|----|----|
| $C_{ies}$ | Input Capacitance            | $V_{CE} = 30V, V_{GE} = 0V,$<br>$f = 1MHz$ | -- | 375 | -- | pF |
| $C_{oes}$ | Output Capacitance           |  | -- | 63  | -- | pF |
| $C_{res}$ | Reverse Transfer Capacitance |  | -- | 13  | -- | pF |

**Switching Characteristics**

|              |                             |  |     |     |         |         |
|--------------|-----------------------------|--|-----|-----|---------|---------|
| $t_{d(on)}$  | Turn-On Delay Time          | $V_{CC} = 300V, I_C = 6.5A,$<br>$R_G = 50\Omega, V_{GE} = 15V,$<br>Inductive Load, $T_C = 25^\circ\text{C}$  | --  | 20  | --      | ns      |
| $t_r$        | Rise Time                   |  | --  | 27  | --      | ns      |
| $t_{d(off)}$ | Turn-Off Delay Time         |  | --  | 70  | 130     | ns      |
| $t_f$        | Fall Time                   |  | --  | 97  | 150     | ns      |
| $E_{on}$     | Turn-On Switching Loss      |  | --  | 85  | --      | $\mu J$ |
| $E_{off}$    | Turn-Off Switching Loss     | --   | 95  | --  | $\mu J$ |         |
| $E_{ts}$     | Total Switching Loss        | --   | 180 | 270 | $\mu J$ |         |
| $t_{d(on)}$  | Turn-On Delay Time          | $V_{CC} = 300V, I_C = 6.5A,$<br>$R_G = 50\Omega, V_{GE} = 15V,$<br>Inductive Load, $T_C = 125^\circ\text{C}$ | --  | 30  | --      | ns      |
| $t_r$        | Rise Time                   |  | --  | 32  | --      | ns      |
| $t_{d(off)}$ | Turn-Off Delay Time         |  | --  | 85  | 200     | ns      |
| $t_f$        | Fall Time                   |  | --  | 168 | 250     | ns      |
| $E_{on}$     | Turn-On Switching Loss      |  | --  | 180 | --      | $\mu J$ |
| $E_{off}$    | Turn-Off Switching Loss     | --   | 165 | --  | $\mu J$ |         |
| $E_{ts}$     | Total Switching Loss        | --   | 345 | 500 | $\mu J$ |         |
| $Q_g$        | Total Gate Charge           | $V_{CE} = 300V, I_C = 6.5A,$<br>$V_{GE} = 15V$   | --  | 25  | 35      | nC      |
| $Q_{ge}$     | Gate-Emitter Charge         |  | --  | 7   | 12      | nC      |
| $Q_{gc}$     | Gate-Collector Charge       |  | --  | 8   | 14      | nC      |
| $L_e$        | Internal Emitter Inductance | Measured 5mm from PKG  | --  | 7.5 | --      | nH      |

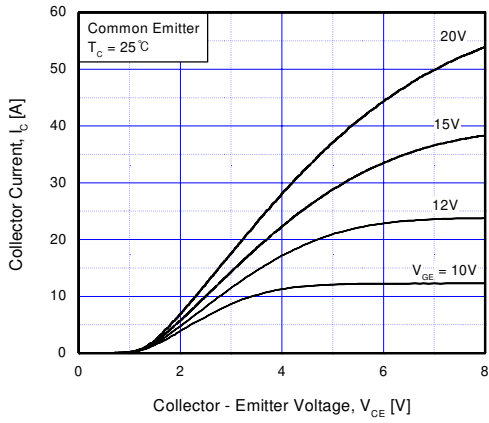


Fig 1. Typical Output Characteristics

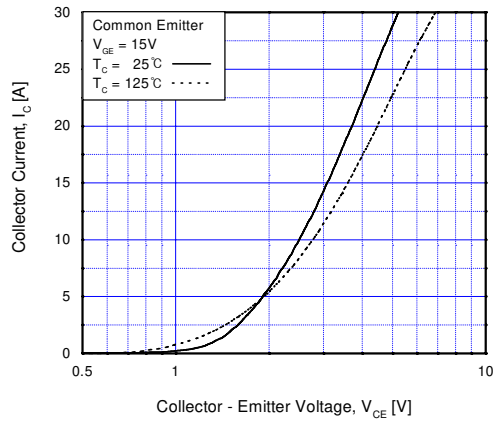


Fig 2. Typical Saturation Voltage Characteristics

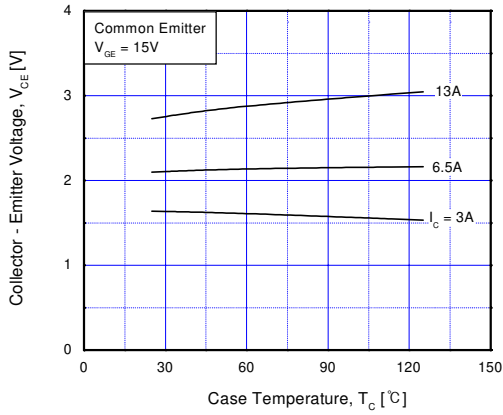


Fig 3. Saturation Voltage vs. Case Temperature at Variant Current Level

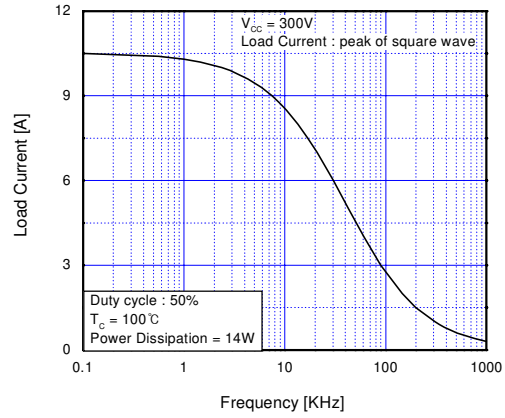


Fig 4. Load Current vs. Frequency

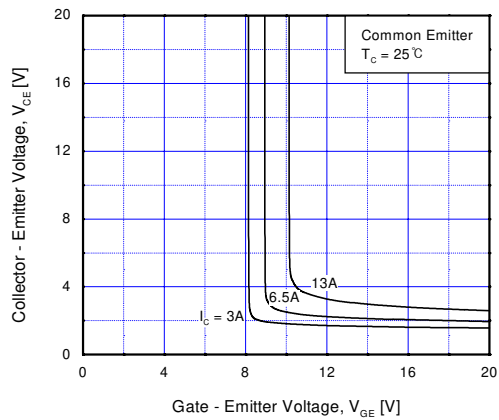


Fig 5. Saturation Voltage vs.  $V_{GE}$

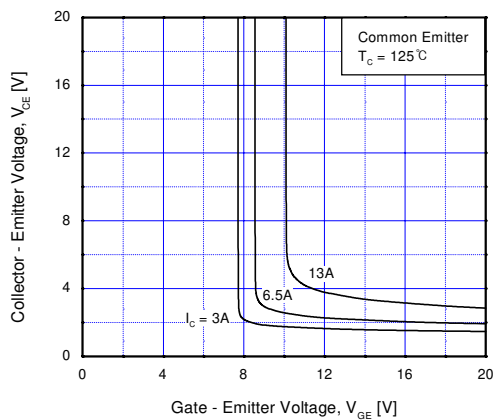


Fig 6. Saturation Voltage vs.  $V_{GE}$

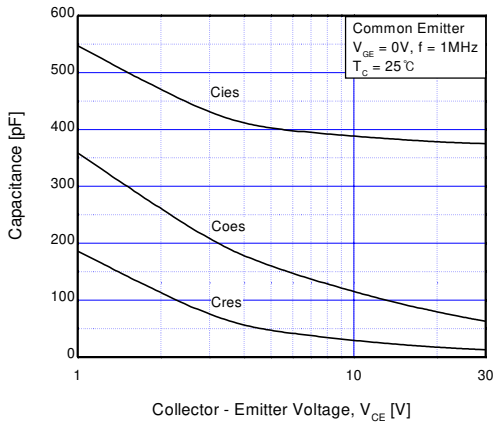


Fig 7. Capacitance Characteristics

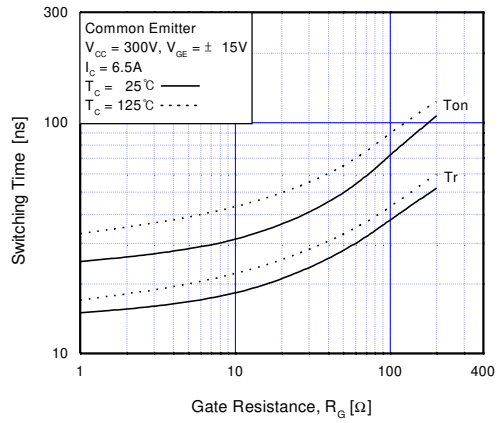


Fig 8. Turn-On Characteristics vs. Gate Resistance

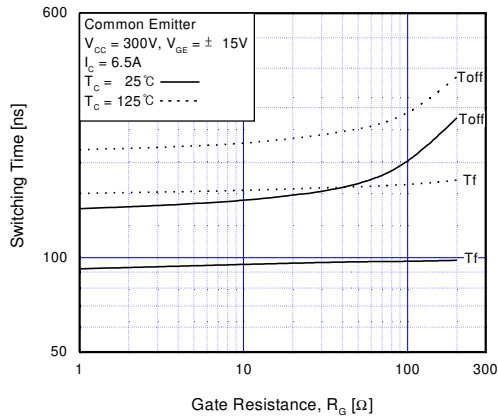


Fig 9. Turn-Off Characteristics vs. Gate Resistance

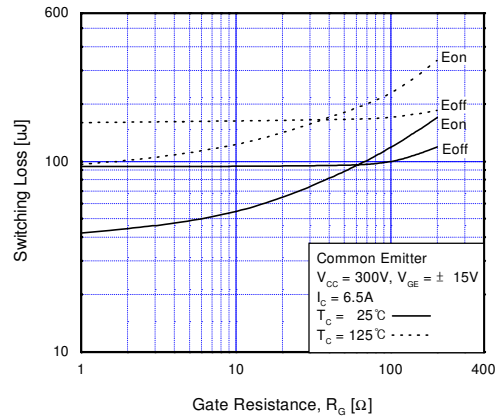


Fig 10. Switching Loss vs. Gate Resistance

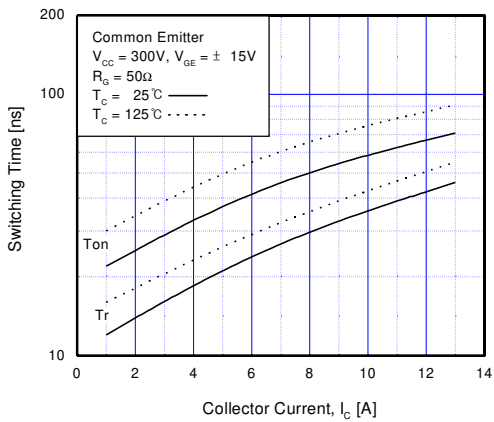


Fig 11. Turn-On Characteristics vs. Collector Current

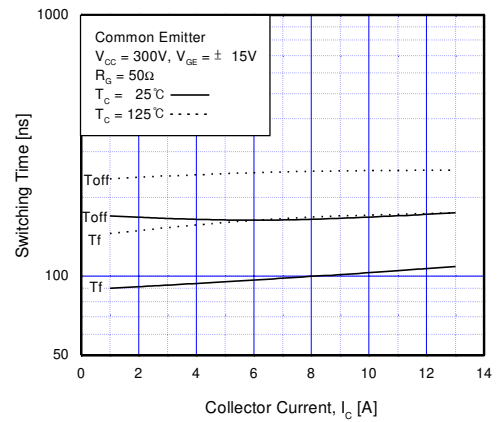
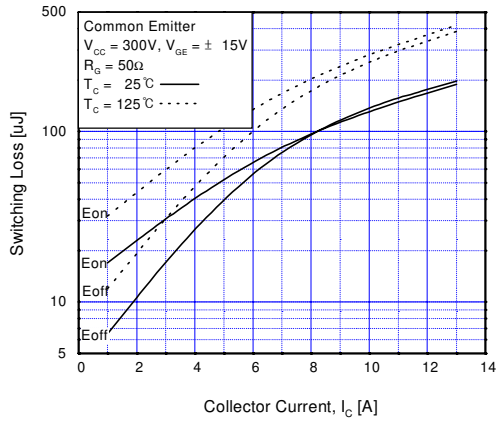
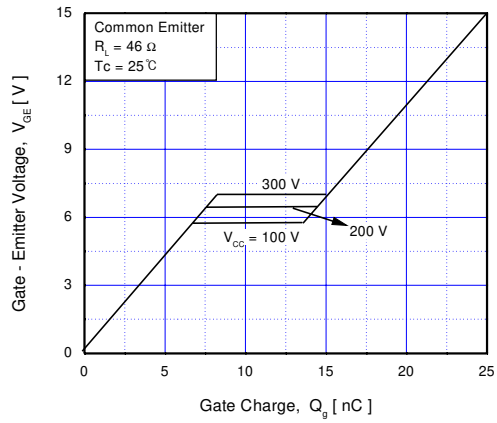


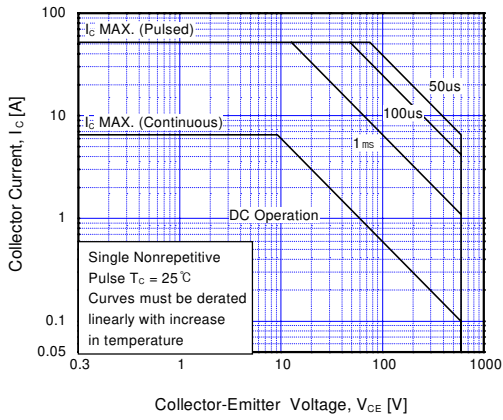
Fig 12. Turn-Off Characteristics vs. Collector Current



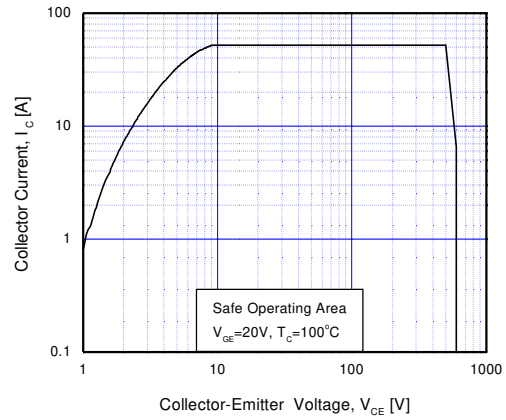
**Fig 13. Switching Loss vs. Collector Current**



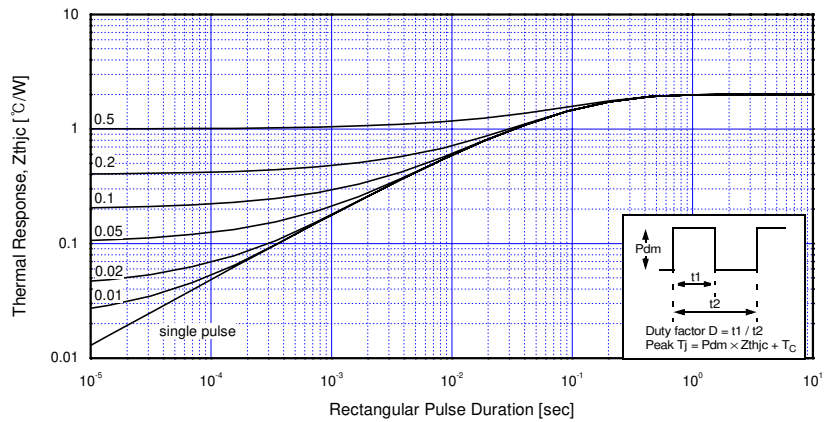
**Fig 14. Gate Charge Characteristics**



**Fig 15. SOA Characteristics**



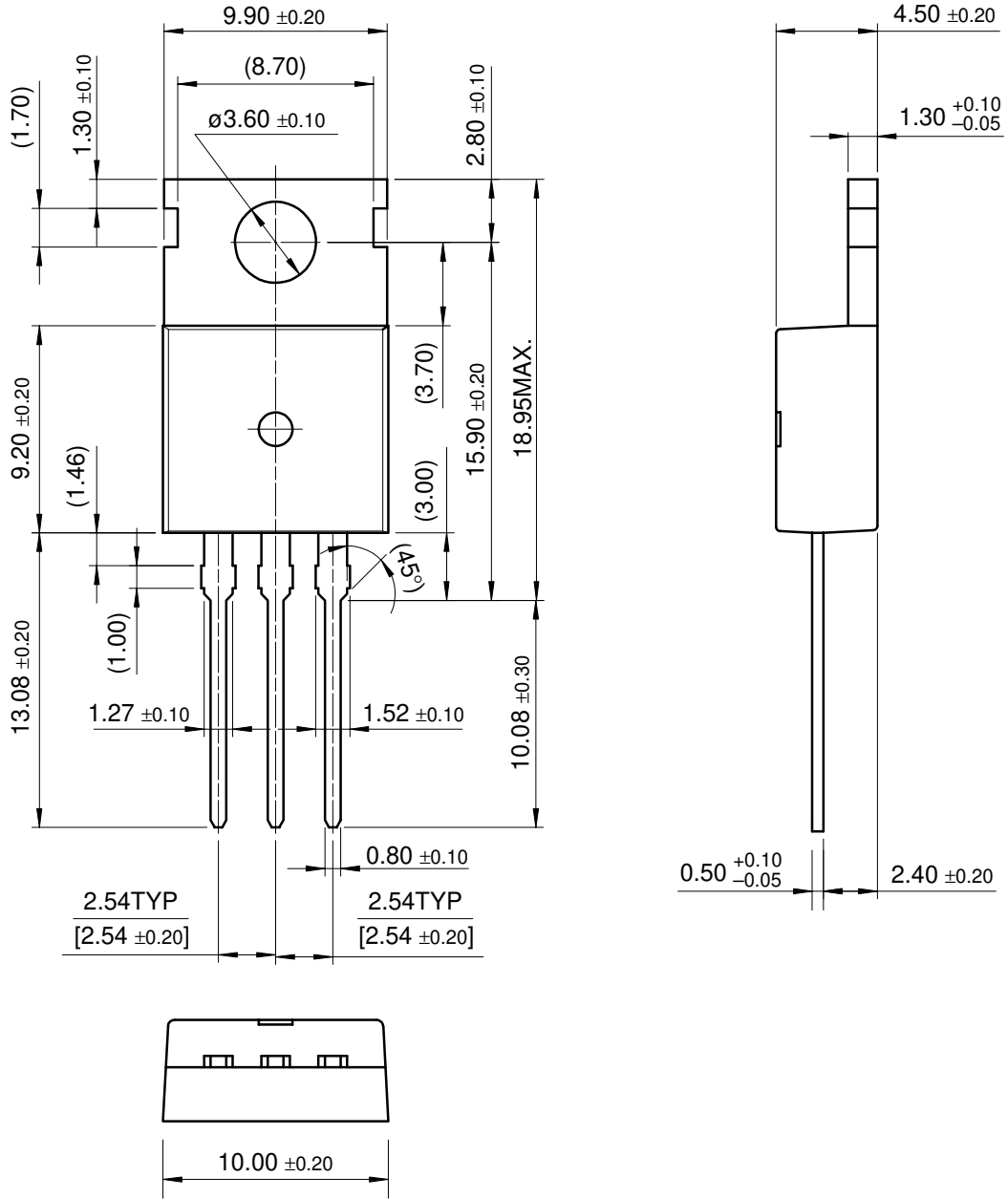
**Fig 16. Turn-Off SOA Characteristics**



**Fig 17. Transient Thermal Impedance of IGBT**

Package Dimension

TO-220



Dimensions in Millimeters

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